

**Search Notes**

Application/Control No.

10/644,809

Examiner

Huy D. Nguyen

Applicant(s)/Patent under  
Reexamination

OKAWA ET AL.

Art Unit

2681

**SEARCHED**

Class	Subclass	Date	Examiner
455	25	6/3/2005	HN
	63.4		
	82		
	562.1		
	575.7		
	121		
	129		
	101		
	13.3		
	19		
	406		
342	367		
	368		
	354		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
455	562.1	6/3/2006	HN
	575.7		
	25		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East; Text Search	6/3/2005	HN
East (USPAT, US-PGPUB, EPO, JPO, DERWENT) - see search history printout.	11/21/2005	HN
East (USPAT, US-PGPUB, EPO, JPO, DERWENT). See search history printout.	5/10/2006	HN
See interference search printout.	5/10/2006	HN